


<b>Search Notes</b>  	<b>Application/Control No.</b>  10617026	<b>Applicant(s)/Patent Under Reexamination</b>  LEE ET AL.
	<b>Examiner</b>  Moon, Seokyun	<b>Art Unit</b>  2629

### SEARCHED

Class	Subclass	Date	Examiner
345	89	1/3/2007	s.m.
	99	1/3/2007	s.m.
	100	1/3/2007	s.m.
	58	1/3/2007	s.m.
	87	1/3/2007	s.m.
	94	1/3/2007	s.m.
	98	1/3/2007	s.m.
	208	1/3/2007	s.m.

### SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, EPO, JPO) Class 345 - Combined with Text Search	1/3/2007	s.m.
EAST (US-PGPUB, USPAT, EPO, JPO) - See Attachment for Search History	1/3/2007	s.m.
EAST (US-PGPUB, USPAT, EPO, JPO) Class 345 - Combined with Text Search	7/7/2008	s.m.
EAST (US-PGPUB, USPAT, EPO, JPO) Text Search - See Attachment for Search History	7/7/2008	s.m.

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
345	89	1/3/2007	s.m.
	99	1/3/2007	s.m.
	100	1/3/2007	s.m.
	58	1/3/2007	s.m.